



# CrossLink-NX sysI/O Usage Guide

## Technical Note

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## Acronyms in This Document

A list of acronyms used in this document.

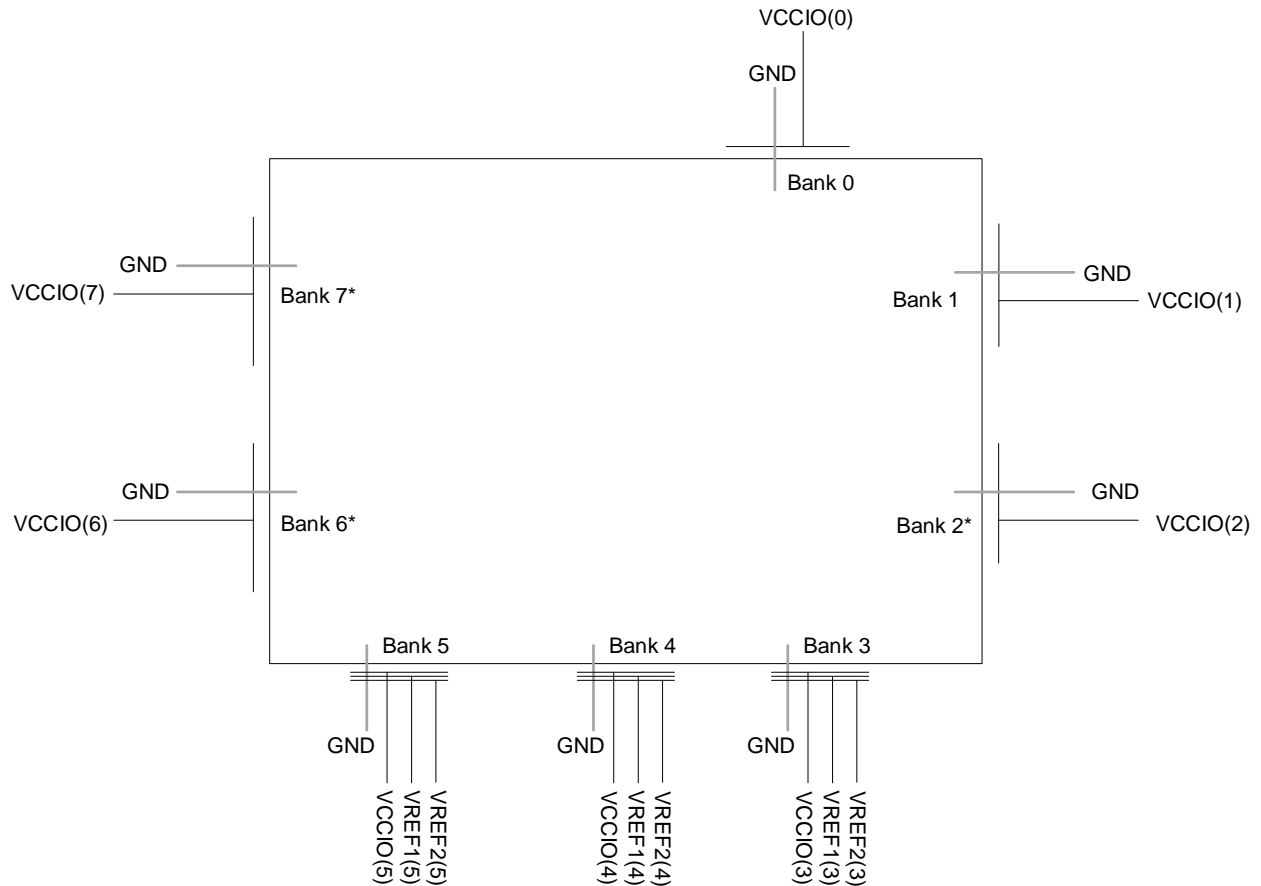
| Acronym | Definition  |
|---------|---|
| DDR     | Double Data Rate                                    |
| HDL     | Hardware Description Language                       |
| LVC MOS | Low Voltage Complementary Metal Oxide Semiconductor |
| LVDS    | Low-Voltage Differential Signaling                  |
| LV TTL  | Low Voltage Transistor-Transistor Logic             |
| PIO     | Programmable Input/Output                           |
| VHDL    | VHSIC Hardware Description Language                 |
| VHSIC   | Very High Speed Integrated Circuit                  |

## 1. Introduction

The Lattice Semiconductor CrossLink-NX™ device family sysI/O™ buffers are designed to support a wide range of interfaces. Two types of I/O are offered, wide range I/O on the top, left and right banks and high performance I/O on the bottom banks only. It gives you the ability to easily interface with other devices using advanced system I/O standards. This technical note provides information on the supported I/O standards and the banking scheme of the CrossLink-NX family. The software attributes/usage are also covered to provide a better understanding of the I/O functionality and placement rules.

## 2. sysI/O Banking Scheme

All CrossLink-NX devices have 8 banks in total. One bank on top, two on left and right, and three on bottom. The higher density CrossLink-NX device, the more pins there are in each bank. Bank 0, Bank 1, Bank 2, Bank 6, and Bank 7 support up to  $V_{CCIO}$  3.3 V while Bank 3, Bank 4, and Bank 5 support up to  $V_{CCIO}$  1.8 V. In addition, Bank 3, Bank 4, and Bank 5 support two VREF inputs for flexibility to receive two different referenced input levels on the same bank. Figure 2.1 shows the location of each bank.



\*Note: Banks are not available for 17K.

Figure 2.1. sysI/O Banking

### 2.1. $V_{CC}$ (1.0 V)

This is the core supply. This  $V_{CC}$  supply is used to power the control logic. The control signals and data signals from the I/O logic are then translated to higher supply of the I/O buffers.

### 2.2. $V_{CCIO}^{[0, 1, 2, 6, 7]}$ (1.2 V/1.5 V/1.8 V/2.5 V/3.3 V)

Bank 0, Bank 1, Bank 2, Bank 6, and Bank 7 have a  $V_{CCIO}$  supply that operates from 3.3 V down to 1.0 V.

### 2.3. $V_{CCIO}^{[3, 4, 5]}$ (1.0 V/1.2 V/1.35 V/1.5 V/1.8 V)

Bank 3, Bank 4, and Bank 5 operate with  $V_{CCIO}$  of 1.8 V down to 1.0 V. Standards such as LVDS, SSTL HSTL, and SLVS are only supported on these three banks.

## 2.4. V<sub>CCAUX</sub> (1.8 V)

In addition to the bank V<sub>CCIO</sub> supplies and a V<sub>CC</sub> core logic supply, CrossLink-NX devices have a V<sub>CCAUX</sub> auxiliary supply that powers the differential and referenced input buffers D-PHY External Power Supplies (1.2 V).



### 3. V<sub>CCIO</sub> Requirement for I/O Standards

Each I/O bank of a CrossLink-NX device has a separate V<sub>CCIO</sub> supply pin that can be connected to 1.0 V, 1.2 V, 1.35 V, 1.5 V, 1.8 V for bottom banks and 1.2 V, 1.5 V, 1.8 V, 2.5 V, 3.3 V for the rest of the banks. These voltages are used to power the output I/O standard and source the drive strength for the output. On the input side, each pad is connected to a set of ratioed input buffers that provide support for the following:

- Fixed threshold 1.0 V/1.2 V input standards
- Ratioed V<sub>CCIO</sub> input standards
- Ratioed V<sub>CCAUX</sub> based 1.8/1.5V LVCMOS inputs.

These three buffers are connected to V<sub>CC</sub>, V<sub>CCIO</sub> and V<sub>CCAUX</sub> respectively.

**Table 3.1. Input Mixed Mode for Wide Range Input Buffers**

| V <sub>CCIO</sub> (V) | Input Signaling (V)            |                |                                   |           |                                  |           |
|-----------------------|--------------------------------|----------------|-----------------------------------|-----------|----------------------------------|-----------|
|                       | LVC MOS10                      | LVC MOS12      | LVC MOS15                         | LVC MOS18 | LVC MOS25                        | LVC MOS33 |
|                       | V <sub>CC</sub> Powered Buffer |                | V <sub>CCAUX</sub> Powered Buffer |           | V <sub>CCIO</sub> Powered Buffer |           |
| 1.2                   | ✓ <sup>2</sup>                 | ✓ <sup>2</sup> | ✓ <sup>1,3</sup>                  | —         | —                                | —         |
| 1.5                   | ✓ <sup>2</sup>                 | ✓ <sup>2</sup> | ✓ <sup>1,3</sup>                  | ✓         | —                                | —         |
| 1.8                   | ✓ <sup>2</sup>                 | ✓ <sup>2</sup> | ✓ <sup>1,3</sup>                  | ✓         | —                                | —         |
| 2.5                   | ✓ <sup>2</sup>                 | ✓ <sup>2</sup> | ✓ <sup>1,3</sup>                  | ✓         | ✓                                | —         |
| 3.3                   | ✓ <sup>2</sup>                 | ✓ <sup>2</sup> | ✓ <sup>1,3</sup>                  | ✓         | ✓ <sup>3</sup>                   | ✓         |

**Notes:**

1. Increased ICC due to underdrive.
2. No HYST.
3. Reduced HYST.

**Table 3.2. Input Mixed Mode for High Performance Input Buffers**

| V <sub>CCIO</sub> (V) | Input Signaling (V)            |            |                                  |            |
|-----------------------|--------------------------------|------------|----------------------------------|------------|
|                       | LVC MOS1.0                     | LVC MOS1.2 | LVC MOS1.5                       | LVC MOS1.8 |
|                       | V <sub>CC</sub> Powered Buffer |            | V <sub>CCIO</sub> Powered Buffer |            |
| 1.0                   | ✓                              |            |                                  |            |
| 1.2                   | ✓                              | ✓          |                                  |            |
| 1.5                   | ✓                              | ✓          | ✓                                |            |
| 1.8                   | ✓                              | ✓          | ✓ <sup>1,2</sup>                 | ✓          |

**Notes:**

1. Increased ICC due to underdrive.
2. Reduced Hysteresis.

## 4. sysI/O Buffer Configurations

This section describes the various sysI/O features available on the CrossLink-NX device.

### 4.1. Programmable Drive Strength

All single-ended drivers have programmable drive strength. [Table 4.1](#) and [Table 4.2](#) show the programmable drive strength of all the I/O standards available in CrossLink-NX. The maximum current allowed per bank as well as the package thermal limit current should be taken into consideration when selecting the drive strength.

**Table 4.1. Programmable Drive Strength Values at Various VCCIO Voltages for Wide Range Output Driver**

| I/O TYPE  | Drive Strength (mA) |
|-----------|---------------------|
| LVC MOS33 | 2, 4, 8, 12, 16     |
| LVC MOS25 | 2, 4, 8, 10         |
| LVC MOS18 | 2, 4, 8             |
| LVC MOS15 | 2, 4                |
| LVC MOS12 | 2, 4                |

**Table 4.2. Programmable Drive Strength Values at Various VCCIO Voltages for High Performance Output Driver**

| I/O TYPE  | Drive Strength (mA) |
|-----------|---------------------|
| LVC MOS18 | 2, 4, 8, 12         |
| LVC MOS15 | 2, 4, 8             |
| LVC MOS12 | 2, 4, 8             |
| LVC MOS10 | 2, 4                |

### 4.2. Programmable Slew Rate

The single-ended output buffer for each I/O pin has programmable output slew rate control that can be configured for either low noise (SLEWRATE=SLOW) or high speed (SLEWRATE=FAST) or in between, (SLEWRATE=MED).

### 4.3. Tristate Control

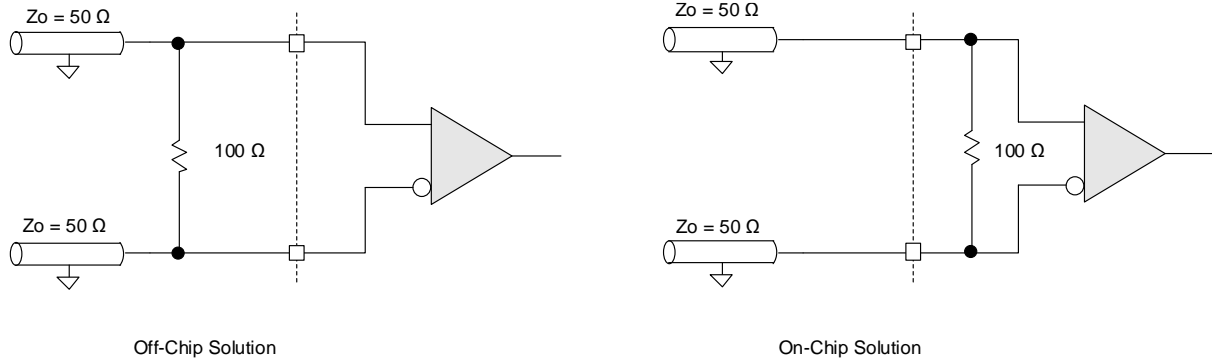
On the output side, each single-ended driver has a separate tristate control. The differential driver has a tristate control as well.

### 4.4. Open Drain Control

In addition to the tristate control, the single-ended drivers also support open drain operation on each I/O independently. Unlike non-open drain output that consists of a source and sink section, an open drain output is composed of only the sink section of the output driver. You can implement an open drain output by turning on the OPENDRAIN attribute in the software

### 4.5. Differential Input Termination

The CrossLink-NX devices support a programmable 100  $\Omega$  input termination between all pairs on the bottom banks. The input termination of 100  $\Omega$  can be programmed between on and off. [Figure 4.1](#) shows the discrete off-chip and on-chip solutions for dedicated, differential input termination.



**Figure 4.1. Off-Chip and On-Chip Solutions**

## 4.6. Programmable Clamp

The buffers on the bottom sysI/O have optional clamp diodes that can be programmable to ON or OFF.

## 5. Software sysI/O Attributes

The sysI/O attributes can be specified in the Hardware Description Language (HDL), using Device Constraint Editor, or in Pre/Post Timing Constraint Editor (.lhc/.pdc).

### 5.1. IO\_TYPE

This attribute is used to set the sysI/O standard for an I/O. The  $V_{CCIO}$  required to set these I/O standards are embedded in the attribute names. [Table 5.1](#) lists the available I/O types.

**Table 5.1. IO\_TYPE Attribute Values**

| sysI/O Signaling Standard        | IO_TYPE     |
|----------------------------------|-------------|
| Default                          | LVCNOS18    |
| LVDS 1.8V                        | LVDS        |
| LVDS 1.8V Emulation              | LVDS        |
| Sub-LVDS                         | SUBLVDS     |
| Sub-LVDS Emulation               | SUBLVDS     |
| Sub-LVDS Emulation High Speed    | SUBLVDSH    |
| SLVS                             | SLVS        |
| MIPI_DPHY                        | MIPI_DPHY   |
| SSTL 1.5V Class I                | SSTL15_I    |
| SSTL 1.5V Class II               | SSTL15_II   |
| SSTL 1.5V Differential Class I   | SSTL15D_I   |
| SSTL 1.5V Differential Class II  | SSTL15D_II  |
| SSTL 1.35V Class I               | SSTL135_I   |
| SSTL 1.35V Class II              | SSTL135_II  |
| SSTL 1.35V Differential Class I  | SSTL135D_I  |
| SSTL 1.35V Differential Class II | SSTL135D_II |
| HSTL 1.5V Class I                | HSTL15_I    |
| HSTL 1.5V Differential Class I   | HSTL15D_I   |
| HSUL 1.2V                        | HSUL12      |
| HSUL 1.2V Differential           | HSUL12D     |
| LVTTTL 3.3V                      | LVTTTL33    |
| LVTTTL 3.3V differential         | LVTTTL33D   |
| LVCNOS 3.3V                      | LVCNOS33    |
| LVCNOS 3.3V Differential         | LVCNOS33D   |
| LVCNOS 2.5V                      | LVCNOS25    |
| LVCNOS 2.5V Differential         | LVCNOS25D   |
| LVCNOS 1.8V Differential         | LVCNOS18    |
| LVCNOS 1.8V High Speed           | LVCNOS18H   |
| LVCNOS 1.5V                      | LVCNOS15    |
| LVCNOS 1.5V High Speed           | LVCNOS15H   |
| LVCNOS 1.2V                      | LVCNOS12    |
| LVCNOS 1.2V High Speed           | LVCNOS12H   |
| LVCNOS 1.0V                      | LVCNOS10    |
| LVCNOS 1.0V High Speed           | LVCNOS10H   |
| LVCNOS 1.0V Referenced           | LVCNOS10R   |

## 5.2. PULLMODE

The PULLMODE attribute can be enabled for each I/O independently. This attribute is available for all the LVTTTL and LVCMOS inputs and bidirectional I/O.

Values: UP, DOWN, NONE, I3C, FAILSAFE

Default: Down when available, None when not available.

## 5.3. CLAMP

The CLAMP option can be enabled for each I/O independently.

Values: ON, OFF

Default: ON for Bank 3, Bank 4, Bank 5 and OFF for Bank 0, Bank 1, Bank 2, Bank 6, Bank 7

## 5.4. HYSTERESIS

The hysteresis option can be used to change the amount of hysteresis for the LVTTTL and LVCMOS input and bidirectional I/O standards. LVCMOS12/12H and LVCMOS10/10H do not support hysteresis.

Values: ON, NA

Default: ON for LVTTTL, and LVCMOS15/18/33 for input and bidirectional standards. Everything else defaulted to NA

## 5.5. VREF

The VREF option is enabled for referenced LVCMOS10 as well as referenced input buffers such as HSTL, SSTL and HSUL.

Values: OFF, VREF1\_LOAD, VREF2\_LOAD

Default: *VREF1\_LOAD* for standards mentioned above, others defaulted to OFF.

## 5.6. OPENDRAIN

The OPENDRAIN option is available for all LVTTTL and LVCMOS.

An I/O can be assigned independently to be an open drain when this attribute is turned on.

Values: OFF, ON

Default: OFF

## 5.7. SLEWRATE

Each I/O pin has an individual slew rate control. This allows you to specify slew rate control on a pin by pin basis. Slew rate control is not a valid attribute for inputs.

Values: SLOW, MED, FAST, NA

Default: SLOW

Hardware default: SLOW

## 5.8. DIFFRESISTOR

This attribute is used to provide differential termination. It is available only for differential I/O types.

Values: OFF, 100

Default: OFF

## 5.9. TERMINATION

The I/O supports single ended input parallel termination to  $V_{CCIO}/2$ . All input parallel terminations use a Thevenin termination scheme.

Values: OFF, 40, 50, 60, 75, 150

Default: OFF

## 5.10. DRIVE

The drive strength attribute is available for the output and bidirectional I/O standards. The default drive value depends on the I/O standard used.

**Table 5.2. DIFFRESISTOR Values**

| Output Standard                | Drive                                | DiffDrive | V <sub>CCIO</sub> |
|--------------------------------|--------------------------------------|-----------|-------------------|
| <b>Single Ended Interfaces</b> |                                      |           |                   |
| LVTTTL33                       | 8 mA, 2 mA, 4 mA, 12 mA, 16 mA, 50RS | —         | 3.3               |
| LVC MOS33                      | 8 mA, 2 mA, 4 mA, 12 mA, 16 mA, 50RS | —         | 3.3               |
| LVC MOS25                      | 8 mA, 2 mA, 4 mA, 12 mA, 50RS        | —         | 2.5               |
| LVC MOS18                      | 8 mA, 2 mA, 4 mA, 50RS               | —         | 1.8               |
| LVC MOS18H                     | 8 mA, 2 mA, 4 mA, 12 mA, 50RS        | —         | 1.8               |
| LVC MOS15                      | 8 mA, 2 mA, 4 mA                     | —         | 1.5               |
| LVC MOS15H                     | 8 mA, 2 mA, 4 mA                     | —         | 1.5               |
| LVC MOS12                      | 8 mA, 2 mA, 4 mA                     | —         | 1.2               |
| LVC MOS12H                     | 8 mA, 2 mA, 4 mA                     | —         | 1.2               |
| LVC MOS10H                     | 8 mA, 2 mA, 4 mA                     | —         | 1                 |
| LVTTTL33 (Open Drain)          | 8 mA, 2 mA, 4 mA, 12 mA              | —         | —                 |
| LVC MOS33 (Open Drain)         | 8 mA, 2 mA, 4 mA, 12 mA              | —         | —                 |
| LVC MOS25 (Open Drain)         | 8 mA, 2 mA, 4 mA, 10 mA              | —         | —                 |
| LVC MOS18 (Open Drain)         | 8 mA, 2 mA, 4 mA                     | —         | —                 |
| LVC MOS18H (Open Drain)        | 8 mA, 2 mA, 4 mA, 12 mA              | —         | —                 |
| LVC MOS15 (Open Drain)         | 8 mA, 2 mA, 4 mA                     | —         | —                 |
| LVC MOS15H (Open Drain)        | 8 mA, 2 mA, 4 mA                     | —         | —                 |
| LVC MOS12 (Open Drain)         | 8 mA, 2 mA, 4 mA                     | —         | —                 |
| LVC MOS12H (Open Drain)        | 8 mA, 2 mA, 4 mA                     | —         | —                 |
| LVC MOS10H (Open Drain)        | 8 mA, 2 mA, 4 mA                     | —         | —                 |
| HSUL12                         | 8 mA, 6 mA, 4 mA                     | —         | 1.2               |
| HSTL15_I                       | 8 mA                                 | —         | 1.5               |
| SSTL15_I                       | 8 mA                                 | —         | 1.5               |
| SSTL15_II                      | 10 mA                                | —         | 1.5               |
| <b>Differential Interfaces</b> |                                      |           |                   |
| LVDS                           | -                                    | 3.5 mA    | 1.8               |
| SLVS                           | -                                    | 2.0 mA    | —                 |
| SUBLVDSE                       | 8 mA                                 | —         | 1.8               |
| SUBLVDSEH                      | 8 mA                                 | —         | 1.8               |
| LVDSE                          | 8 mA                                 | —         | 2.5               |
| HSUL12D                        | 4 mA, 6 mA, 8 mA                     | —         | 1.2               |
| HSTL15D_I                      | 8 mA                                 | —         | 1.5               |
| SSTL15D_I                      | 8 mA                                 | —         | 1.5               |
| SSTL15D_II                     | 10 mA                                | —         | 1.5               |

| Output Standard | Drive                         | DiffDrive | V <sub>ccio</sub> |
|-----------------|-------------------------------|-----------|-------------------|
| SSTL135D_I      | 8 mA                          | —         | 1.35              |
| SSTL135D_II     | 10 mA                         | —         | 1.35              |
| LVTTL33D        | 8 mA, 2 mA, 4 mA, 12 mA, 50RS | —         | 3.3               |
| LVCOS33D        | 8 mA, 2 mA, 4 mA, 12 mA, 50RS | —         | 3.3               |
| LVCOS25D        | 8 mA, 2 mA, 4 mA, 12 mA, 50RS | —         | 2.5               |

## Technical Support Assistance

Submit a technical support case through [www.latticesemi.com/techsupport](http://www.latticesemi.com/techsupport).



## Revision History

Revision 1.0, November 2019

| Section | Change Summary  |
|---------|-----------------|
| All     | Initial release |



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